

Search Notes

Application/Control No.

10/500,210

Examiner

W. Patty Chen

Applicant(s)/Patent under
Reexamination

YAMASHITA ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed previously cited references	12/18/2006	WPC